



Docket Number: 061063-0317066 Client Reference: OSP-18862

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re the Application of

AKIRA OKUBO, et al.

Group Art Unit: 1763

Application No.: 10/544,178

Examiner: Unassigned

Filed: April 24, 2006

Confirmation No.: 8571

For: INSPECTION METHOD, MANUFACTURING METHOD OF PIECE FOR ANALYSIS, ANALYSIS METHOD, ANALYZER, MANUFACTURING METHOD OF SOI WAFER, AND SOI

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INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR 1.56, the attention of the Patent and Trademark Office is hereby directed to the reference listed on the attached PTO-1449. Copies of cited U.S. patents and patent application publications are not included. Copies of foreign patent documents and non-patent literature are included. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference be made of record therein and appear among the "References Cited" on any patent to issue therefrom. Applicants respectfully request the Examiner return an initialed copy of the enclosed Form PTO-1449 to Applicants with the next Office communication to indicate that the reference(s) has been considered, per MPEP § 609.

This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of the first Office Action on the merits in the present application. No certification or fee is required.

The reference was cited in the International Search Report. An English language version of the International Search Report is attached for the Examiner's information. Please note EP 738004 and JP 2001-319954 cited on the International Search Report were previously filed in the U.S. Patent and Trademark Office on April 24, 2006, therefore, they are not enclosed. Also, please note the enclosed document includes an English abstract and English translation of paragraph 6 on pages 100-103.

Respectfully Submitted,

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